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Photolithographically Manufactured Acrylate Polymer Multimode Optical Waveguide Loss Design Rules

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- 1. Motivation:
 - 1. Optical versus Electronic interconnect
 - 2. Waveguide design rules
- 2. Photolithographic fabrication of acrylate polymer waveguides
- 3. Measurement technique
- 4. Loss measurement of waveguide components design rules
 - 1. Straight waveguides
 - 2. Crossings
 - 3. Bends
 - 4. Tapers
 - 5. Tapered bends
- 5. Optical system design



Optical versus Electronic Interconnect

- □ Copper tracks become inefficient as data rates rise above 10 Gb/s
 - Skin effects in the conductors,
 - Cross-talk,
 - Electromagnetic Interference (EMI),
 - Reflection,
 - Signal loss and manufacture cost increases.
- Optical interconnect has potential benefits
 - Less delay due to no RC components,
 - High speed travel in optical materials,
 - Low propagation loss 0.03 ~ 0.06 dB/cm at 850 nm wavelength in waveguide < 50 \times 50 μm in cross-section,
 - Do not require impedance matching,
 - Wavelength division multiplexing is achievable.



Fabrication Parameters

- □ The optical loss depends on several factors:
 - Material,
 - Fabrication
 - Measurement Technique
- Dependence Photolithographically fabricated by Exxelis Ltd. using e-beam mask
- □ Truemode[®] acrylate polymer formulation
- □ Core refractive index 1.5560
- □ Cladding refractive index 1.5264
- □ NA = 0.302
- □ Cross sections typically 50 µm 50 µm and 70 µm 70 µm square



Electrical System with Optical Interconnect







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Photolithographic fabrication of waveguides, $50 \ \mu m \times 50 \ \mu m$ Core





Waveguides Samples – Top View





90° Crossings



Bends



50° Crossings

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Waveguide Output Facet Photographs





VCSEL illuminated

Under nomarski microscope

□ Photolithographicly fabricated by Exxelis, 50 μ m × 50 μ m waveguide □ Cut with a dicing saw, unpolished



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Optical Loss Measurement





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Design Rules for Inter-waveguide Cross Talk



□ 70 µm × 70 µm waveguide cross sections and 10 cm long
□ Waveguide end facets diced but unpolished scatters light into cladding
□ In the cladding power drops linearly at a rate of 0.011 dB/µm
□ Crosstalk reduced to -30 dB for waveguides 1 mm apart



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Schematic Diagram Of Waveguide Crossings at 90° and at an Arbitrary Angle, **θ**





Design Rules for Arbitrary Angle Crossings



□ Loss of 0.023 dB per 90° crossing consistent with other reports □ The output power dropped by 0.5% at each 90° crossing □ The loss per crossing (L_c) depends on crossing angle (θ), $L_c=1.0779 \cdot \theta^{-0.8727.}$



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Optical Power Loss in 90° Waveguide Bends



Schematic diagram of one set of curved waveguides.



Light through a bent waveguide of R = 5.5 mm - 34.5 mm

- Radius *R*, varied between 5.5 mm < R < 35 mm, ΔR = 1 mm
- Light lost due to scattering, mode miss-match loss, radiation loss, reflection and back-scattering
- Illuminated by a MM fibre with a red-laser.



Loss of Waveguide Bends



Width (µm)	Optimum Radius (mm)	Minimum Loss (dB)
50	13.5	0.74
75	15.3	0.91
100	17.7	1.18



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Design Rules for Tapered Bends



The input section w_{in} = 50 μm, and its length I_{in} = 11.5 mm
The tapered bend transforms the waveguide width from w_{in}, to w_{out}
The width of the tapered bends varies linearly along its length
Output straight waveguide length I_{out} = 24.5 mm.
Output widths w_{out} = 10 μm, 20 μm, 25 μm, 30 μm and 40 μm



Misalignment Tolerance of a Tapered Bend



□ Dashed lines correspond to the boundaries of the w_{in} = 50 µm tapered bend

Dotted lines correspond to the boundaries of the 25 µm bend
Tapered bend has more misalignment tolerance for a slight loss penalty



Product of Maximum Transmission And Misalignment Tolerance 0.70.6Transmitted 0.5



The product of transmission and misalignment tolerance is a constant which increases linearly with TR such that the product = 0.650TR - 0.09□ This product is independent of the bend radius as experimental points almost coincide. 23



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System Demonstrator



Fully connected waveguide layout using design rules

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Conclusions and Acknowledgement

□ Characterised photolithographically manufactured acrylate polymer multimode waveguide by measuring the optical loss of key waveguide components.

□ Design rules derived from the experimental measurement to assist optical system designers to optimise OPCB layout.

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Thanks for Your Attention